

## N-Channel and P-Channel 30V(D-S) MOSFET

Product summary			
$V_{DS}$	30	-30	V
$R_{DS(ON)}$ (at $V_{GS}=10V$ ) Typ.	6.5	9	m $\Omega$
$R_{DS(ON)}$ (at $V_{GS}=4.5V$ ) Typ.	10	15	m $\Omega$
$I_D$ ( $T_A=25^{\circ}C$ )	40	-40	A

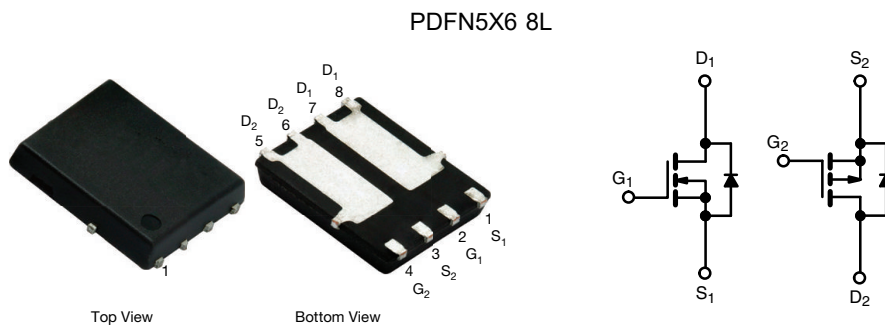
### Features

- Excellent package for heat dissipation
- Trench Power LV MOSFET technology

### Applications

- Power management functions
- Load switch

### Pin Configuration



### Packing Information

Device	Package	Reel Size	Quantity(Min. Package)
ECAP40C03B	PDFN5X6-8L	13"	5000pcs

### Absolute Maximum Ratings (at $T_A=25^{\circ}C$ Unless Otherwise Noted)

Symbol	Parameter		N-Rating	P-Rating	Units
$V_{DS}$	Drain-Source Voltage		30	-30	V
$V_{GS}$	Gate-Source Voltage		$\pm 20$	$\pm 20$	V
$I_D$	Continuous Drain Current <sup>A</sup>	$T_A=25^{\circ}C$ <sup>A</sup>	11	-11	A
		$T_A=70^{\circ}C$ <sup>A</sup>	8.8	-8.8	
		$T_C=25^{\circ}C$	40	-40	
		$T_C=70^{\circ}C$	32	-32	
$I_{DM}$	Pulse Drain Current Tested <sup>B</sup>		140	-160	A
$E_{AS}$	Single Pulse Avalanche Energy <sup>C</sup>		56	90	mJ
$P_D$	Power Dissipation <sup>A</sup>	$T_A=25^{\circ}C$	2.5	2.5	W
	Power Dissipation <sup>D</sup>	$T_C=25^{\circ}C$	50	54	
$T_J, T_{STG}$	Junction and Storage Temperature Range		-55 to +150	-55 to +150	$^{\circ}C$

## Thermal Characteristics

Symbol	Parameter	NMOS	PMOS	Units
$R_{\theta JA}$	Thermal Resistance-Junction to ambient <sup>A</sup>	50	50	°C/W
$R_{\theta JC}$	Thermal Resistance-Junction to Case	2.5	2.3	°C/W

## N-Channel Electrical Characteristics (at $T_J = 25^\circ\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
<b>Static Parameters</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	30	--	--	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=30V, V_{GS}=0V$	--	--	1	$\mu A$
$I_{GSS}$	Gate-Body Leakage Current	$V_{DS}=0V, V_{GS}=\pm 20V$	--	--	$\pm 100$	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	1.0	1.5	2.5	V
$R_{DS(on)}$	Drain-Source On-State Resistance <sup>E</sup>	$V_{GS}=10V, I_D=20A$	--	6.5	8.5	m $\Omega$
		$V_{GS}=4.5V, I_D=10A$	--	10	14	m $\Omega$
$V_{SD}$	Diode Forward Voltage	$I_S=20A, V_{GS}=0V$	--	--	1.2	V
$I_S$	Maximum Body-Diode Continuous Current		--	--	40	A
<b>Dynamic Parameters <sup>F</sup></b>						
$C_{iss}$	Input Capacitance	$V_{GS}=0V, V_{DS}=15V$ $f=1\text{MHz}$	--	1050	--	pF
$C_{oss}$	Output Capacitance		--	180	--	pF
$C_{rss}$	Reverse Transfer Capacitance		--	160	--	pF
$Q_g$	Total Gate Charge	$V_{DS}=15V, I_D=20A$ $V_{GS}=10V$	--	23.6	--	nC
$Q_{gs}$	Gate-Source Charge		--	3.9	--	nC
$Q_{gd}$	Gate-Drain Charge		--	7	--	nC
$t_{D(on)}$	Turn-on Delay Time	$V_{DD}=15V$ $I_D=20A, R_{Gen}=2.2\Omega,$ $V_{GS}=10V$	--	7	--	ns
$t_r$	Turn-on Rise Time		--	19	--	ns
$t_{D(off)}$	Turn-off Delay Time		--	24	--	ns
$t_f$	Turn-off Fall Time		--	24	--	ns
$t_{rr}$	Reverse recovery time	$I_F=20A,$ $di/dt=100\text{ A/uS}$	--	5	--	ns
$Q_{rr}$	Reverse recovery charge		--	0.2	--	nC

A. The data tested by surface mounted on a 1 inch x 1 inch FR-4 board with 2OZ copper.in the still air environment with  $T_A = 25^\circ\text{C}$ .The maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. Repetitive rating: pulse width limited by max. junction temperature.

C. NMOS:  $T_J=25^\circ\text{C}$ ,  $V_{DD}=25V$ ,  $V_G=10V$ ,  $R_G=25\Omega$ ,  $L=0.5\text{mH}$ ,  $I_{AS}=15A$ .

PMOS:  $T_J=25^\circ\text{C}$ ,  $V_{DD}=-25V$ ,  $V_G=-10V$ ,  $R_G=25\Omega$ ,  $L=0.5\text{mH}$ ,  $I_{AS}=-19A$ .

D.  $P_D$  is based on max. junction temperature, using junction-case thermal resistance.

E. Pulse Test: Pulse Width $\leq 300\mu s$ , Duty cycle  $\leq 2\%$ .

F. Guaranteed by design, not subject to production testing.

## P-Channel Electrical Characteristics (at $T_J = 25^\circ\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	Condition	Min.	Typ.	Max.	Units
<b>Static Parameters</b>						
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=-250\mu A$	-30	--	--	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=-30V, V_{GS}=0V$	--	--	-1	$\mu A$
$I_{GSS}$	Gate-Body Leakage Current	$V_{DS}=0V, V_{GS}=\pm 20V$	--	--	$\pm 100$	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=-250\mu A$	-1.2	-1.8	-2.6	V
$R_{DS(ON)}$	Drain-Source On-State Resistance <sup>E</sup>	$V_{GS}=-10V, I_D=-20A$	--	9	12	m $\Omega$
		$V_{GS}=-4.5V, I_D=-10A$	--	15	20	m $\Omega$
$V_{SD}$	Diode Forward Voltage	$I_S=-20A, V_{GS}=0V$	--	--	-1.2	V
$I_{SM}$	Maximum Body-Diode Continuous Current		--	--	-40	A
<b>Dynamic Parameters <sup>F</sup></b>						
$C_{iss}$	Input Capacitance	$V_{GS}=0V, V_{DS}=-15V$ $f=1MHz$	--	1860	--	pF
$C_{oss}$	Output Capacitance		--	310	--	pF
$C_{rss}$	Reverse Transfer Capacitance		--	280	--	pF
$Q_g$	Total Gate Charge	$V_{DS}=-15V, I_D=-20A$ $V_{GS}=-10V$	--	38	--	nC
$Q_{gs}$	Gate-Source Charge		--	6	--	nC
$Q_{gd}$	Gate-Drain Charge		--	10	--	nC
$t_{D(on)}$	Turn-on Delay Time	$V_{DD}=-15V$ $I_D=-20A,$ $R_{GEN}=2.2\Omega,$ $V_{GS}=-10V$	--	8	--	ns
$t_r$	Turn-on Rise Time		--	6	--	ns
$t_{D(off)}$	Turn-off Delay Time		--	108	--	ns
$t_f$	Turn-off Fall Time		--	69	--	ns

E. Pulse Test: Pulse Width  $\leq 300\mu s$ , Duty cycle  $\leq 2\%$ .

F. Guaranteed by design, not subject to production testing.

## N-Channel Typical Characteristics

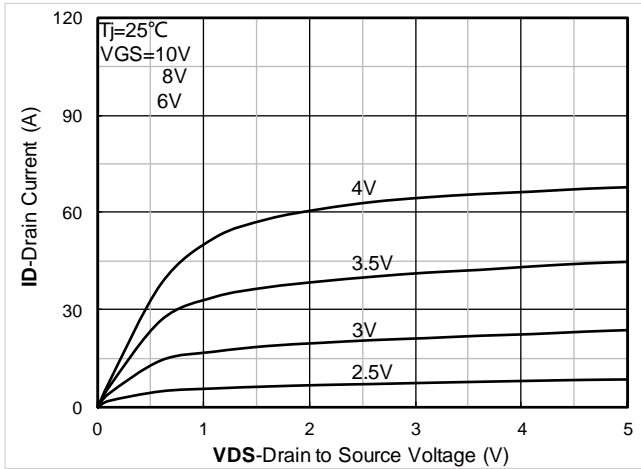


Figure 1. Output Characteristics

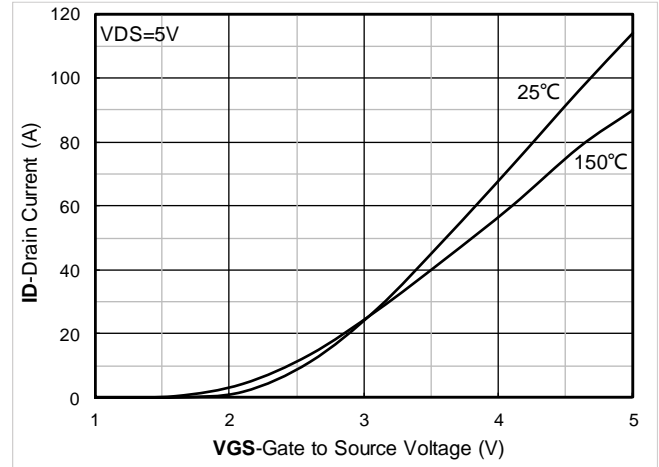


Figure 2. Transfer Characteristics

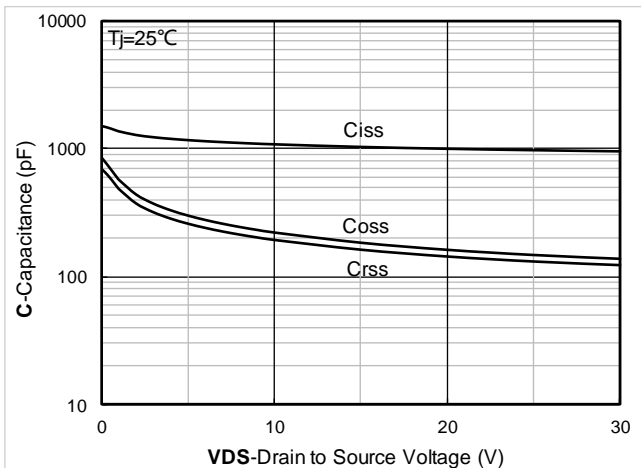


Figure 3. Capacitance Characteristics

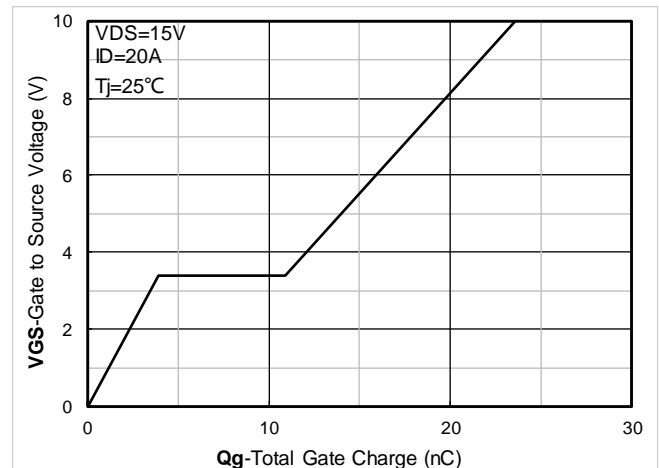


Figure 4. Gate Charge

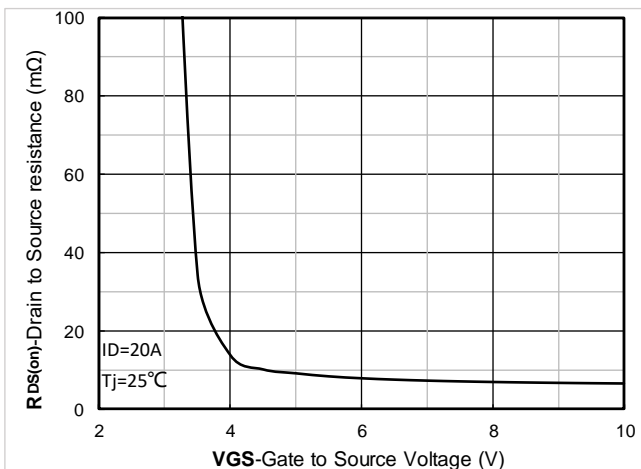


Figure 5. On-Resistance vs Gate to Source Voltage

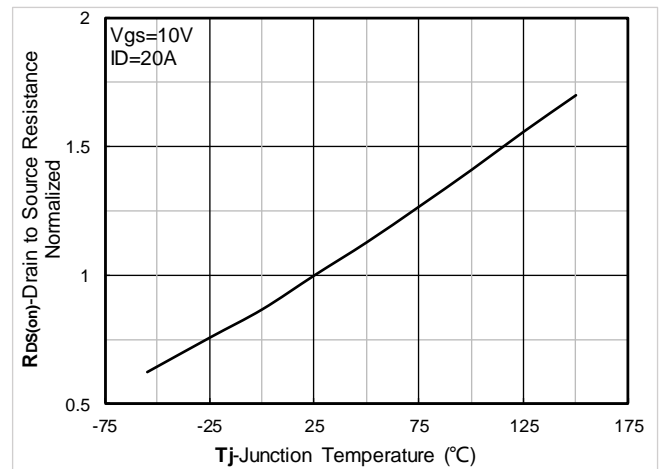


Figure 6. Normalized On-Resistance

## N-Channel Typical Characteristics

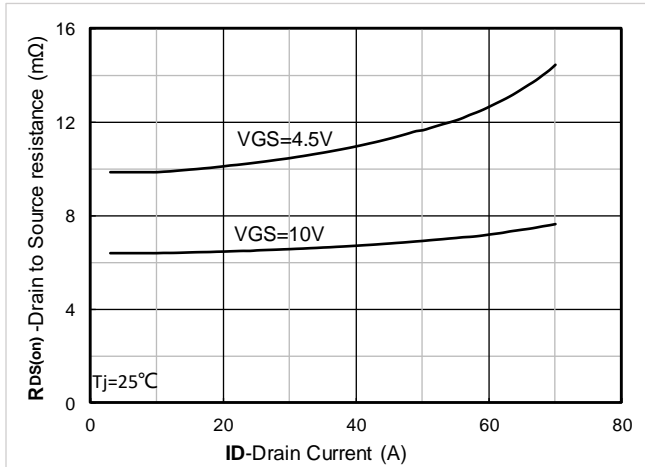


Figure 7.  $R_{DS(on)}$  VS Drain Current

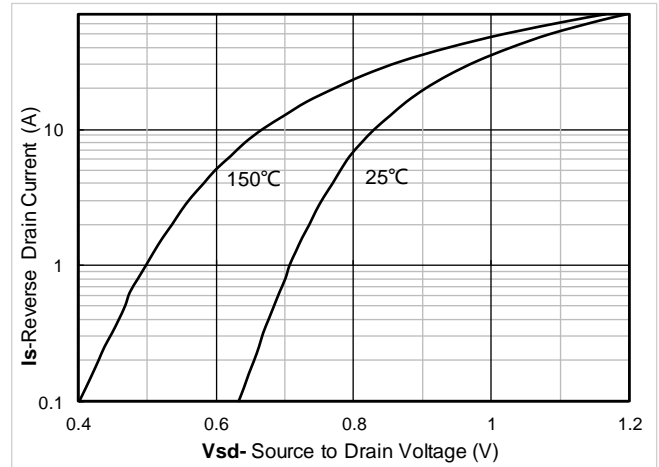


Figure 8. Forward characteristics of reverse diode

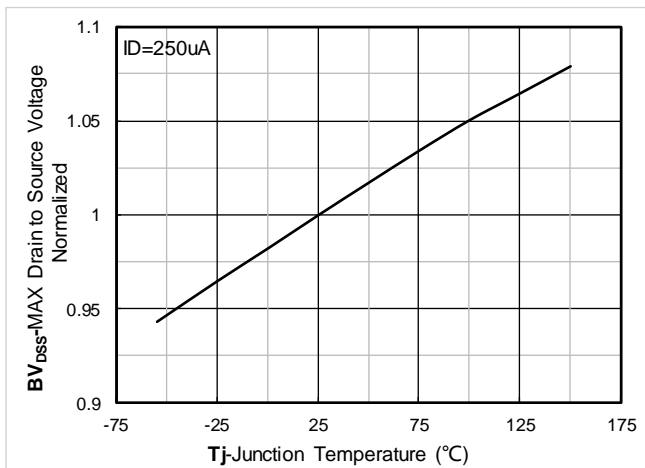


Figure 9. Normalized breakdown voltage

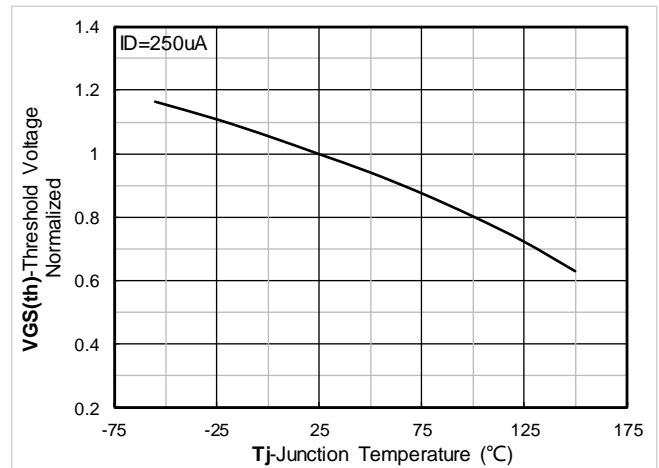


Figure 10. Normalized Threshold voltage

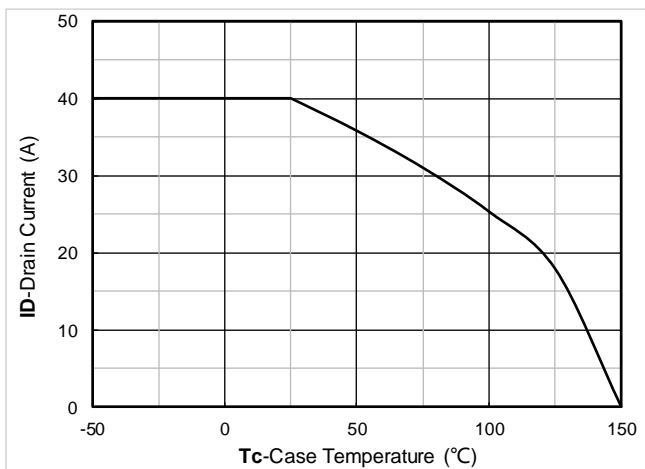


Figure 11. Current dissipation

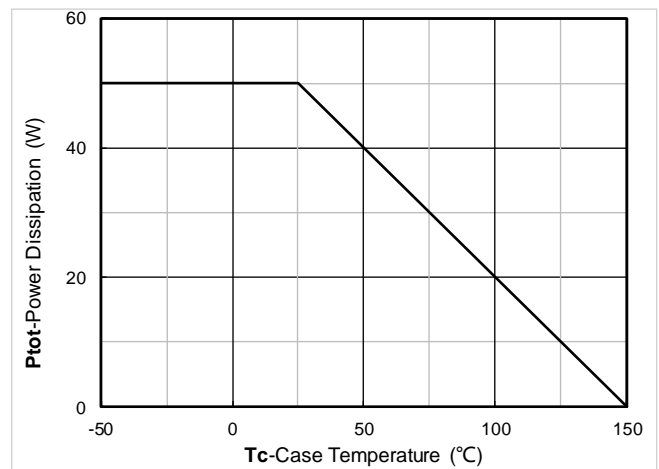


Figure 12. Power dissipation

## N-Channel Typical Characteristics

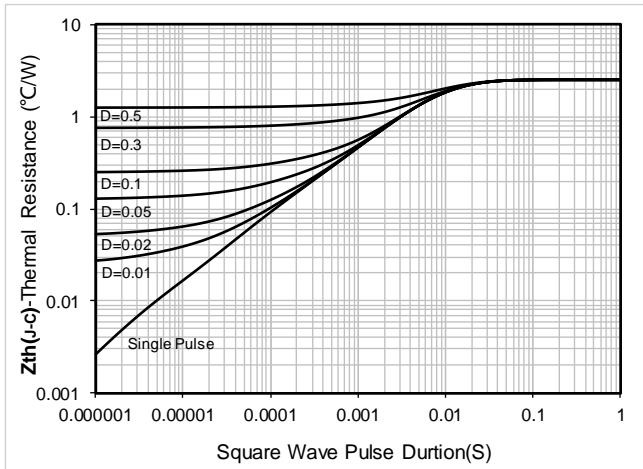


Figure 13. Maximum Transient Thermal Impedance

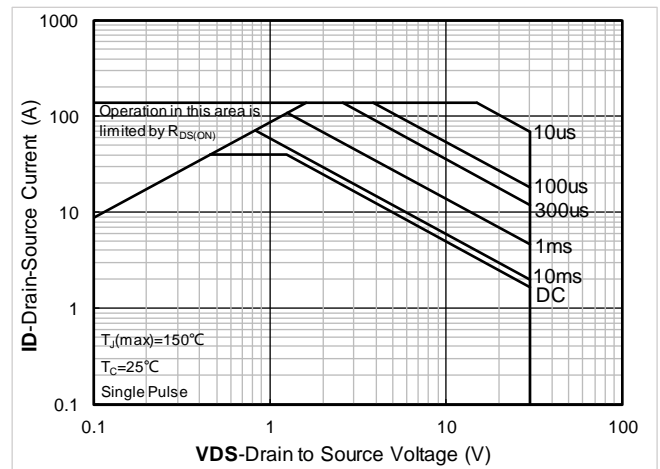


Figure 14. Safe Operation Area

## P-Channel Typical Characteristics

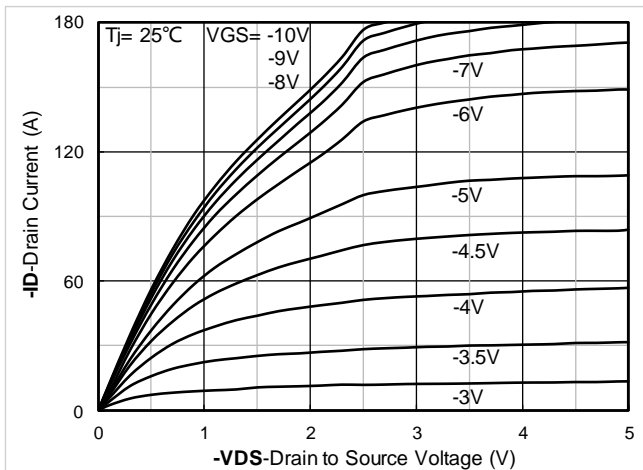


Figure 1. Output Characteristics

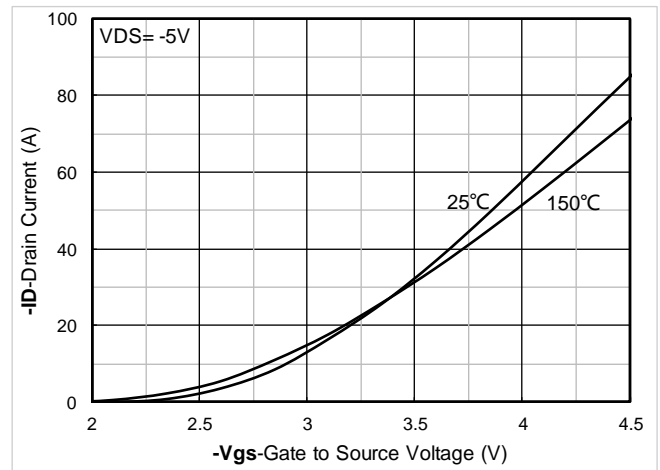


Figure 2. Transfer Characteristics

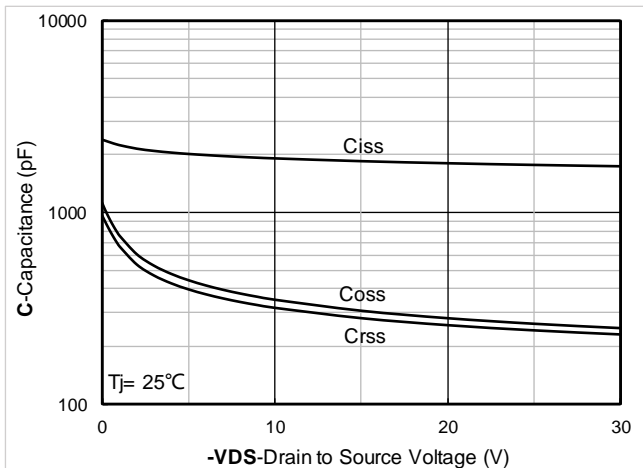


Figure 3. Capacitance Characteristics

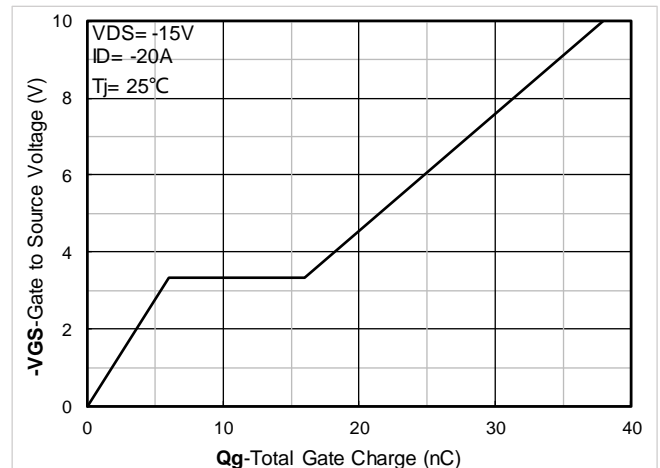


Figure 4. Gate Charge

## P-Channel Typical Characteristics

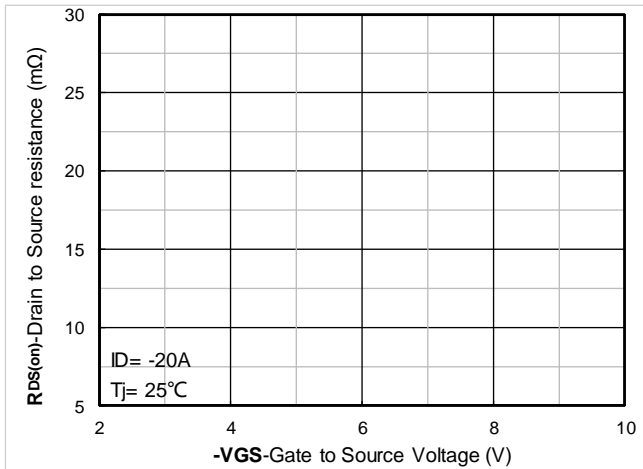


Figure 5. On-Resistance vs Gate to Source Voltage

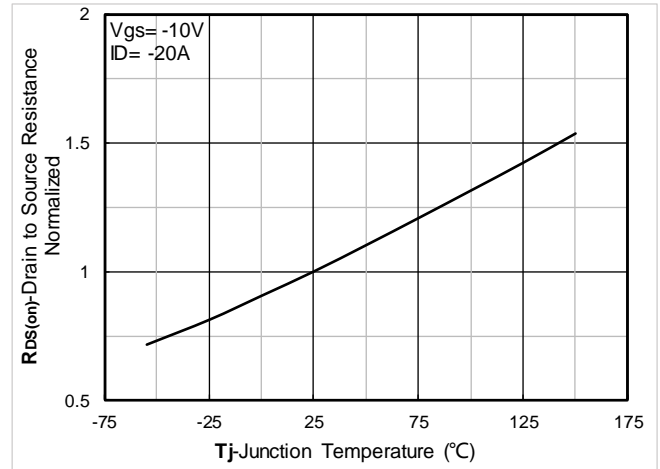


Figure 6. Normalized On-Resistance

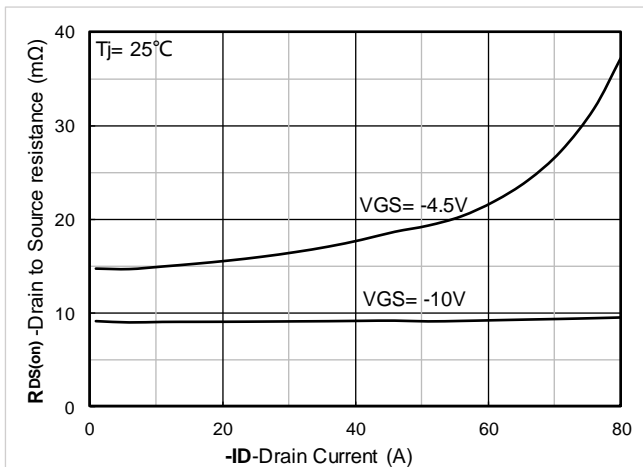


Figure 7.  $R_{DS(on)}$  VS Drain Current

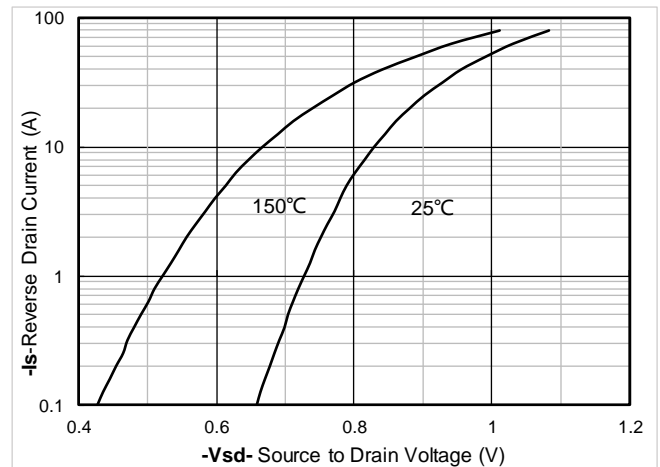


Figure 8. Forward characteristics of reverse diode

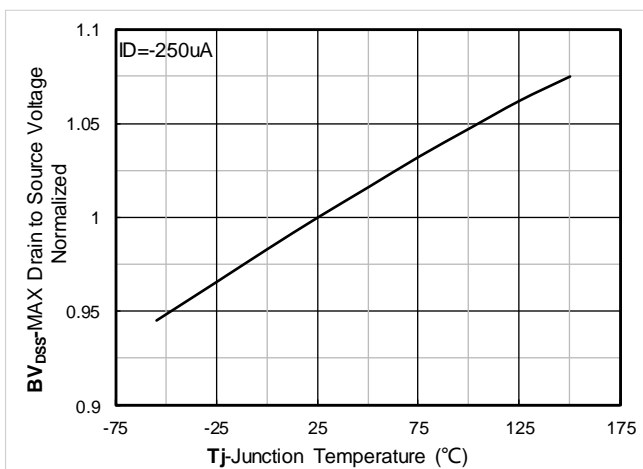


Figure 9. Normalized breakdown voltage

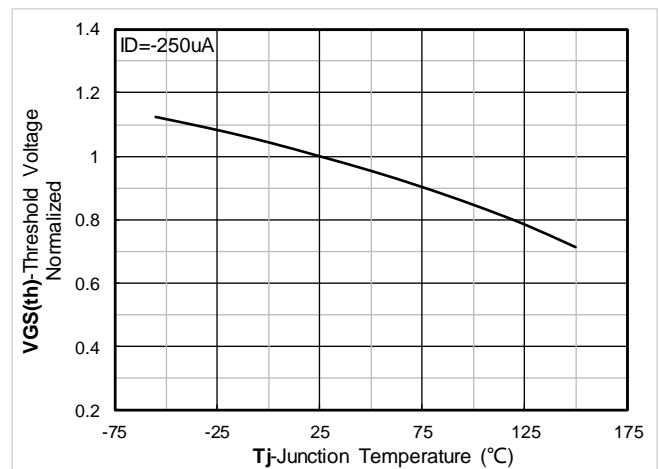


Figure 10. Normalized Threshold voltage

## P-Channel Typical Characteristics

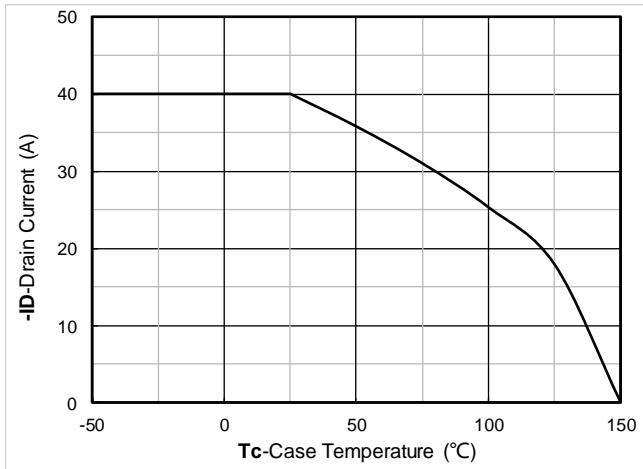


Figure 11. Current dissipation

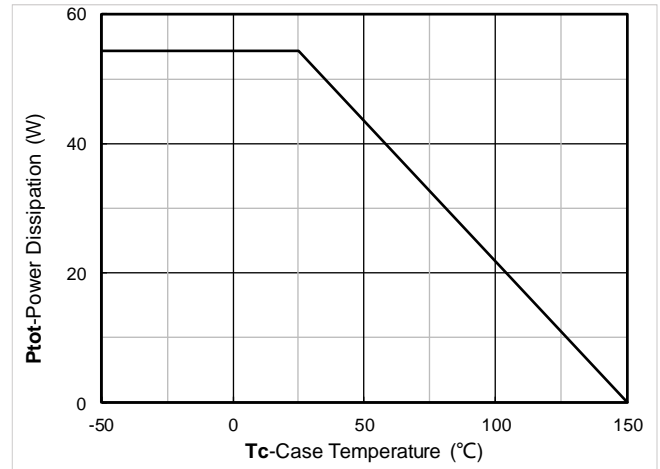


Figure 12. Power dissipation

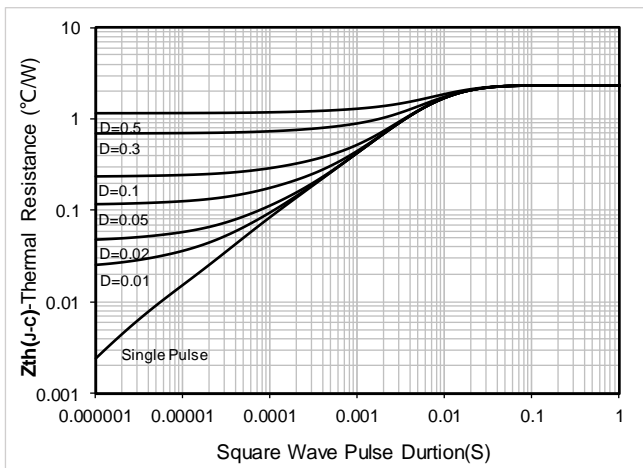


Figure 13. Maximum Transient Thermal Impedance

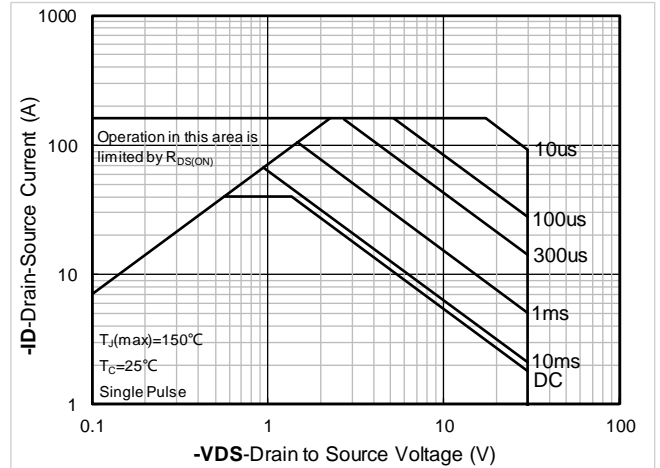
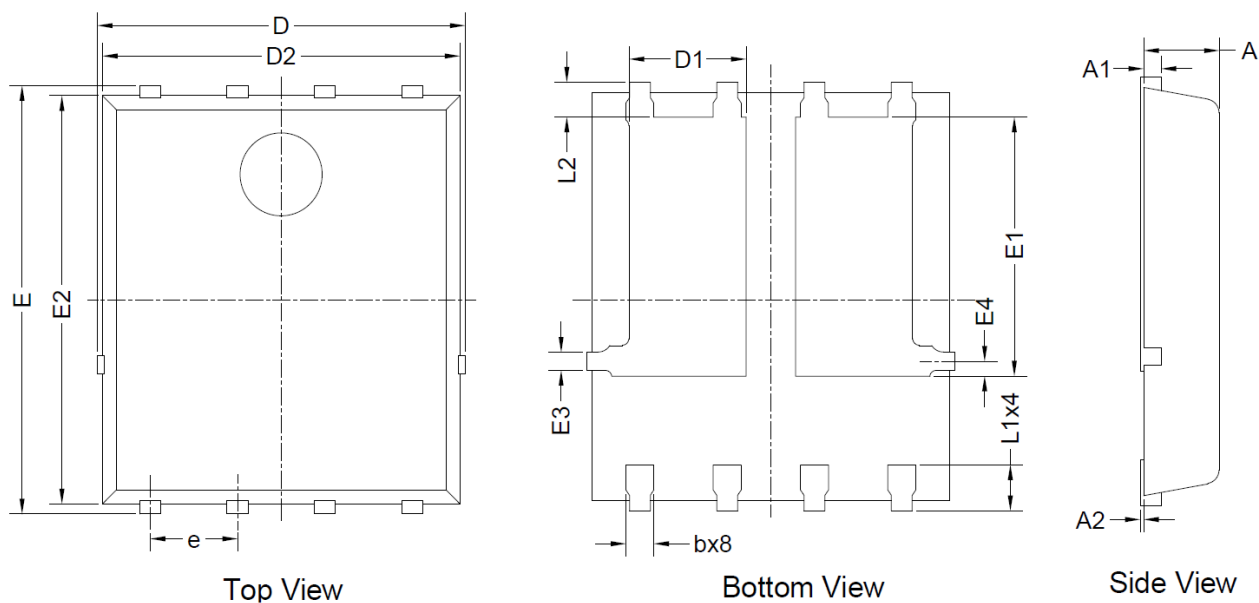


Figure 14. Safe Operation Area



## PDFN5X6-8L Package Information



SYMBOL	MILLIMETER		
	MIN	NOM	MAX
D	5.15	5.35	5.55
E	5.95	6.15	6.35
A	1.00	1.10	1.20
A1	0.254 BSC		
A2			0.10
D1	1.50	1.70	1.90
E1	3.52	3.72	3.92
D2	5.00	5.20	5.40
E2	5.66	5.86	6.06
E3	0.254 REF		
E4	0.21 REF		
L1	0.56	0.66	0.76
L2	0.50 BSC		
b	0.31	0.41	0.51
e	1.27 BSC		